

# MOS FIELD EFFECT TRANSISTOR

# 2SK3433

## SWITCHING

## N-CHANNEL POWER MOS FET

## DESCRIPTION

The 2SK3433 is N-channel MOS Field Effect Transistor designed for high current switching applications.

## FEATURES

- Super low on-state resistance:
- $R_{\text{DS(on)1}}$  = 26 m $\Omega$  MAX. (Vgs = 10 V, ID = 20 A)
- $R_{\text{DS(on)2}}$  = 41 m $\Omega$  MAX. (Vgs = 4.0 V, ID = 20 A)
- Low Ciss: Ciss = 1500 pF TYP.
- Built-in gate protection diode

## ABSOLUTE MAXIMUM RATINGS (TA = 25°C)

Drain to Source Voltage (Vgs = 0 V)	Vdss	60	V
Gate to Source Voltage (VDS = 0 V)	Vgss	±20	V
Drain Current (DC) (Tc = 25°C)	ID(DC)	±40	А
Drain Current (pulse) Note1	D(pulse)	±80	А
Total Power Dissipation (Tc = 25°C)	Р⊤	47	W
Total Power Dissipation (T <sub>A</sub> = 25°C)	Р⊤	1.5	W
Channel Temperature	Tch	150	°C
Storage Temperature	Tstg	–55 to +150	°C
Single Avalanche Current Note2	las	21	А
Single Avalanche Energy <sup>Note2</sup>	Eas	44	mJ

## Notes 1. $PW \leq$ 10 $\mu s, \, Duty \, cycle \leq$ 1%

**2.** Starting T<sub>ch</sub> = 25°C, V<sub>DD</sub> = 30 V, R<sub>G</sub> = 25  $\Omega$ , V<sub>GS</sub> = 20  $\rightarrow$  0 V

## **ORDERING INFORMATION**

PART NUMBER	PACKAGE	
2SK3433	TO-220AB	
2SK3433-S	TO-262	
2SK3433-ZJ	TO-263	
2SK3433-Z	TO-220SMD <sup>Note</sup>	

Note TO-220SMD package is produced only in Japan.



(TO-220AB)

(TO-262)



(TO-263, TO-220SMD)



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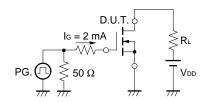
ELECTRICAL CHARACTERISTICS (TA = 25°C)

CHARACTERISTICS	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Zero Gate Voltage Drain Current	IDSS	Vds = 60 V, Vgs = 0 V			10	μA
Gate Leakage Current	lgss	$V_{GS} = \pm 20 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$			±10	μA
Gate Cut-off Voltage	VGS(off)	Vds = 10 V, Id = 1 mA	1.5	2.0	2.5	V
Forward Transfer Admittance	y <sub>fs</sub>	Vds = 10 V, Id = 20 A	11	22		S
Drain to Source On-state Resistance	RDS(on)1	Vgs = 10 V, I₂ = 20 A		22	26	mΩ
	RDS(on)2	Vgs = 4.0 V, Id = 20 A		29	41	mΩ
Input Capacitance	Ciss	V <sub>DS</sub> = 10 V		1500		pF
Output Capacitance	Coss	V <sub>GS</sub> = 0 V		250		pF
Reverse Transfer Capacitance	Crss	f = 1 MHz		120		pF
Turn-on Delay Time	td(on)	Vdd = 30 V, Id = 20 A		35		ns
Rise Time	tr	Vgs = 10 V		320		ns
Turn-off Delay Time	td(off)	R <sub>G</sub> = 10 Ω		89		ns
Fall Time	tr			120		ns
Total Gate Charge	Q <sub>G</sub>	V <sub>DD</sub> = 48 V		30		nC
Gate to Source Charge	Q <sub>GS</sub>	Vgs = 10 V		5		nC
Gate to Drain Charge	Qgd	ID = 40 A		8		nC
Body Diode Forward Voltage	VF(S-D)	IF = 40 A, VGS = 0 V		1.0		V
Reverse Recovery Time	trr	IF = 40 A, VGs = 0 V		44		ns
Reverse Recovery Charge	Qrr	di/dt = 100 A/µs		60		nC

## TEST CIRCUIT 1 AVALANCHE CAPABILITY

# $R_{G} = 25 \Omega$ $P_{G} = 25 \Omega$ $V_{GS} = 20 \rightarrow 0 V$ $M_{M} = M_{M}$ $V_{DD}$ $V_{DD}$

## **TEST CIRCUIT 3 GATE CHARGE**



## RL VGS Wave Form UD VDD VDD VGS 0 10% VGS 0 10% VGS VGS 0 10% VGS 0 10% VGS VGS VGS 0 10% VGS 0 10% VGS 0 10%

90%

90%

tf

toff

10%

**TEST CIRCUIT 2 SWITCHING TIME** 

D.U.T.

Rg

PG.

τ

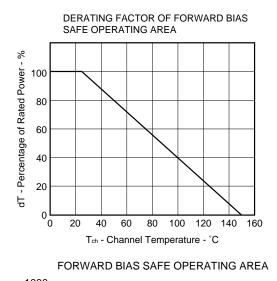
Duty Cycle  $\leq 1\%$ 

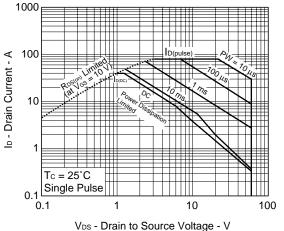
 $\tau = 1 \, \mu s$ 

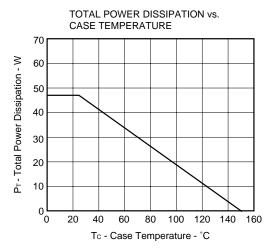
Vgs

0

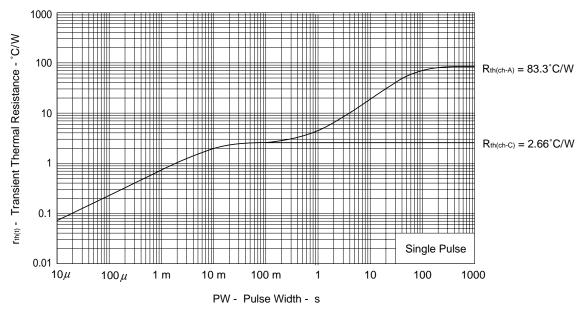
## TYPICAL CHARACTERISTICS (TA = 25°C)







TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



Data Sheet D14602EJ4V0DS

1000

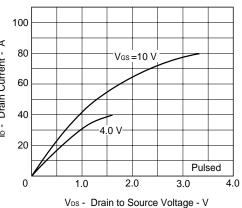
Pulsed

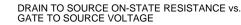
- Drain Current - A 01 ∢ 80 Drain Current 60 40°C A = 25°C 75°C 40 - 0 1 -150°C 20  $V_{DS} = 10 V$ 0.1 5 4 6 2 3 1 0 VGs - Gate to Source Voltage - V FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT <u>с</u>т -<u></u>တု 100 Drain to Source On-state Resistance 50 yts. - Forward Transfer Admittance - S 0.00 1000 Vos = 10 V -----Pulsed 40 30 T<sub>A</sub> = 150°C 75°C 25°C -40°C 20 10 ΠШ RDS(on) -0 <sup>L</sup> 0 0.1 10 100 1 ID - Drain Current - A DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT Drain to Source On-state Resistance -  $m\Omega$ 3.0 80 Pulsed > 70 Gate Cut-off Voltage -2.5 60 2.0 50 1.5 40 Vgs= 4.0 V 30 1.0 **T**||| -----. 20 10 V V<sub>GS(off)</sub> 0.5 10 RDS(on) -0 0∟ 0.1 -50 10 100

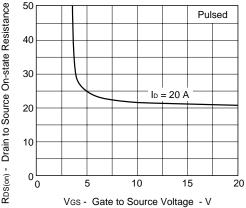
ID - Drain Current - A

FORWARD TRANSFER CHARACTERISTICS

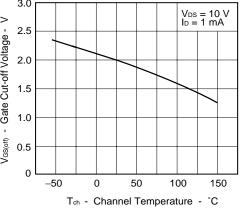




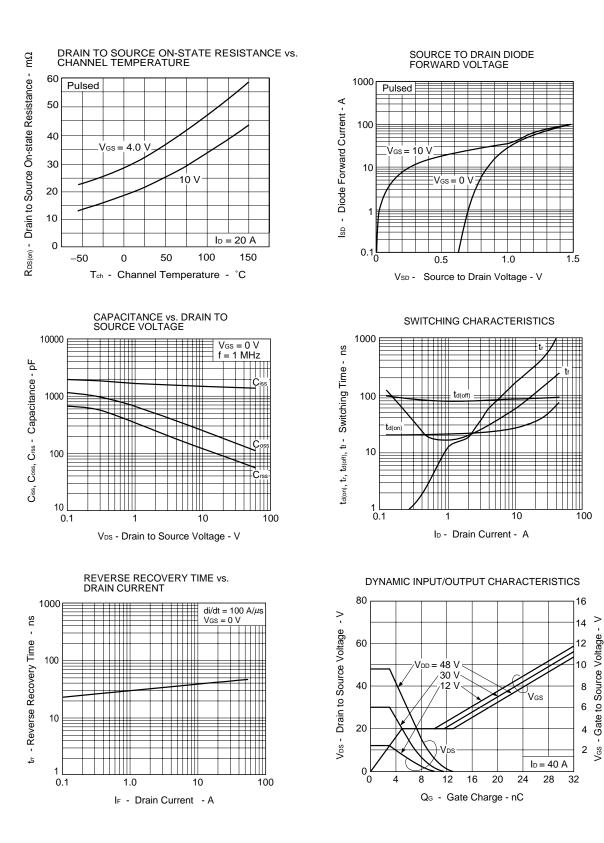




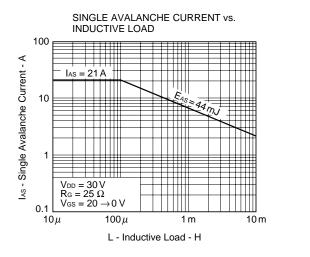


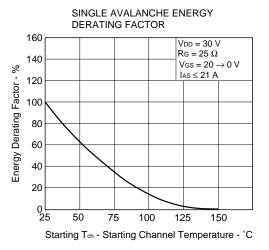


NEC



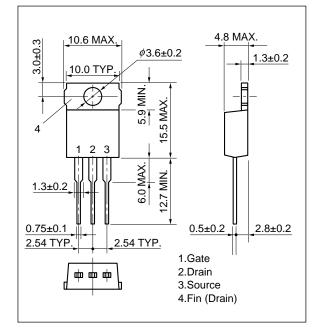
Data Sheet D14602EJ4V0DS

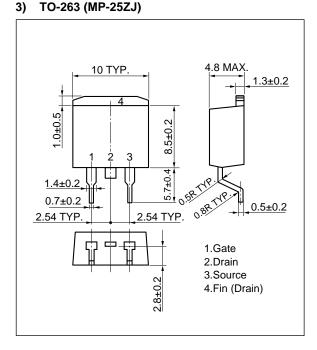




## \* PACKAGE DRAWINGS (Unit: mm)

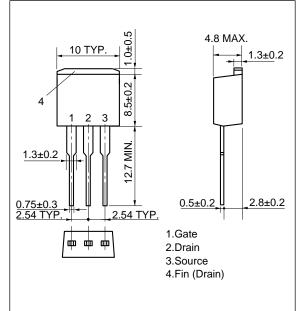
## 1) TO-220AB (MP-25)



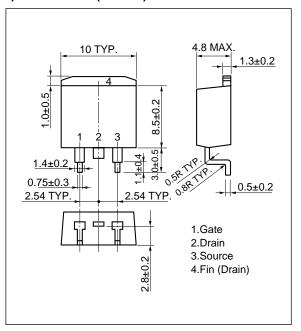


Remark

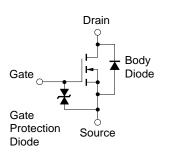
## 2) TO-262 (MP-25 Fin Cut)



4) TO-220SMD (MP-25Z) Note



## **EQUIVALENT CIRCUIT**



**Note** This Package is produced only in Japan.

The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

Data Sheet D14602EJ4V0DS

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